C112-E013

Access to your success
SHIMADZU

PDA-8000

Shimadzu
Optical Emission
Spectrometer

A Spark for a New Dimension

PDA-8000

Shimadzu Optical Emission Spectrometer

A New Design of Spectrometer with Higher Stability

High accuracy and stability measurement achieved by the latest optical design

A Novel Excitation Unit

Equipped with real-time energy monitoring

Sophisticated Software

Total support for control and management of the instrument with an intuitive interface

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A New Design of Spectrometer with Higher Stability

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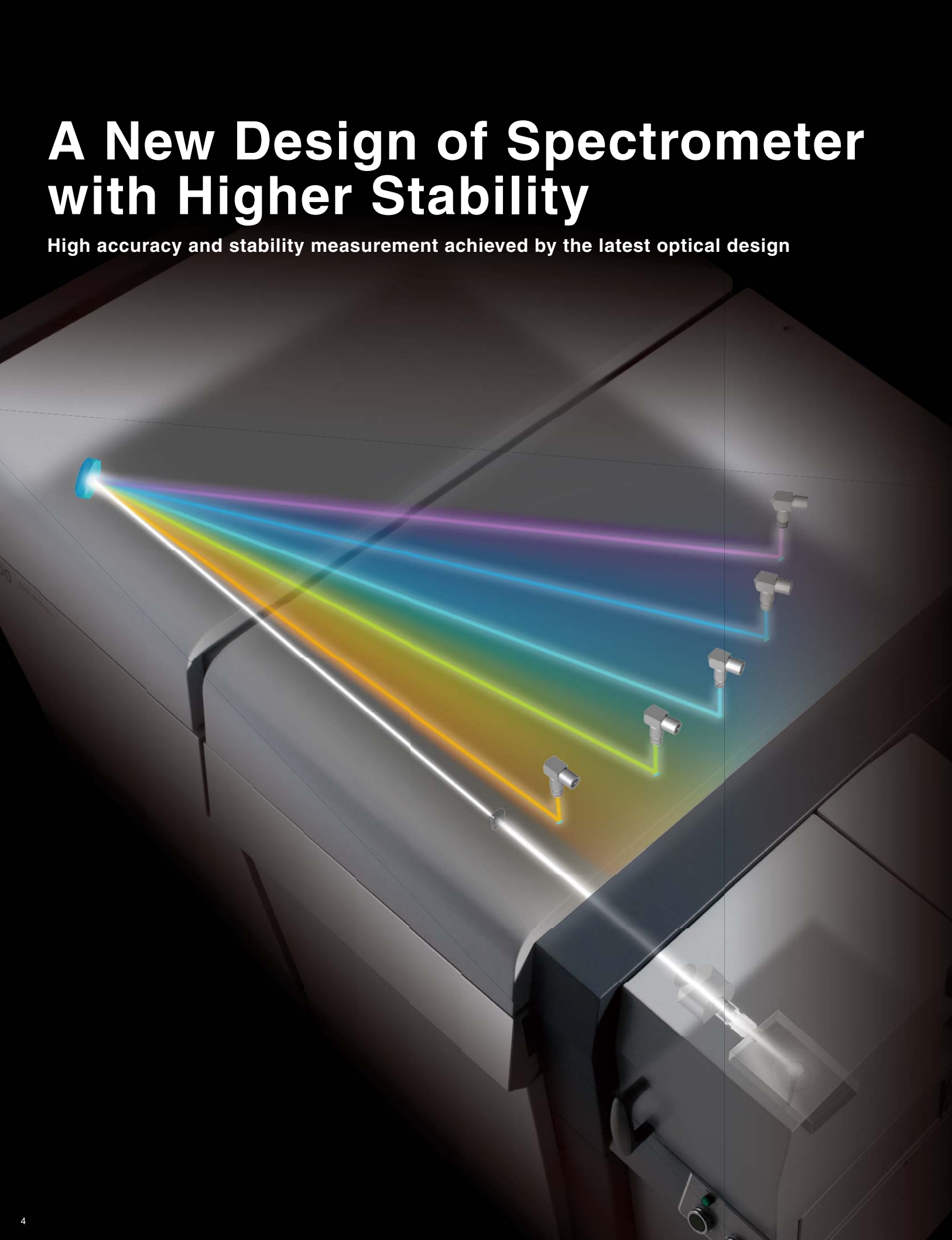


More Precise Analysis Achieved with a High-Resolution Spectrometer

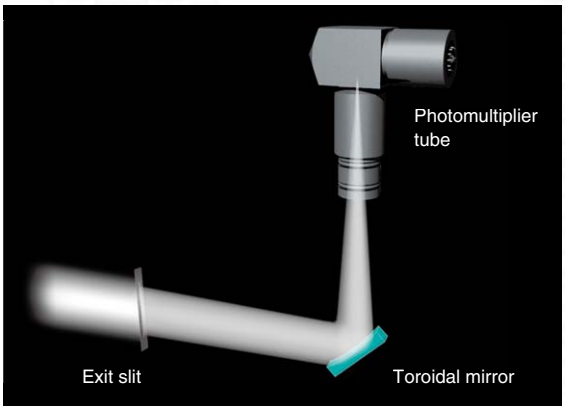
Using a Paschen-Runge Spectrometer with the focal length of 1000mm, and a diffraction grating suitable for each of ferrous or non-ferrous application, PDA-8000 offers high-resolution measurements with less spectral interference over a wide wavelength range.

Stable and Proven Vacuum Spectrometer

Oxygen inside the spectrometer needs to be removed because it absorbs spectral lines in the vacuum-ultraviolet wavelength range, and some important elements in material analysis have spectral lines in this range, including Phosphorus, Sulfur and Nitrogen.
PDA-8000 uses a proven vacuum monochromator to provide stable spectroscopic analysis.

Light Detector Condensing System

Light passed through the exit slit is focused on the photosensitive surface of a photomultiplier tube by a toroidal mirror. This optical design enables stable measurement.



High Responsiveness to Changes in the Environment

The spectrometer is made from materials that change little with temperature. In addition, by being located in the thermostatic chamber with enhanced thermal insulation performance, changes in the ambient temperature do not affect the instrument, permitting more precise analysis. (Ambient temperature 15 to 30 °C, ±5 °C/hour max.)

Main Fields of Application

Iron and steel

Aluminum base metal, rolling industry

Cast iron

Other metals

- Quality control by rapid analysis in the furnace at each manufacturing stage
- Analysis to determine compliance with standards
- Materials receiving inspection

Machinery, Automotive, Shipbuilding

- Analysis to determine compliance with standards
- Materials receiving inspection

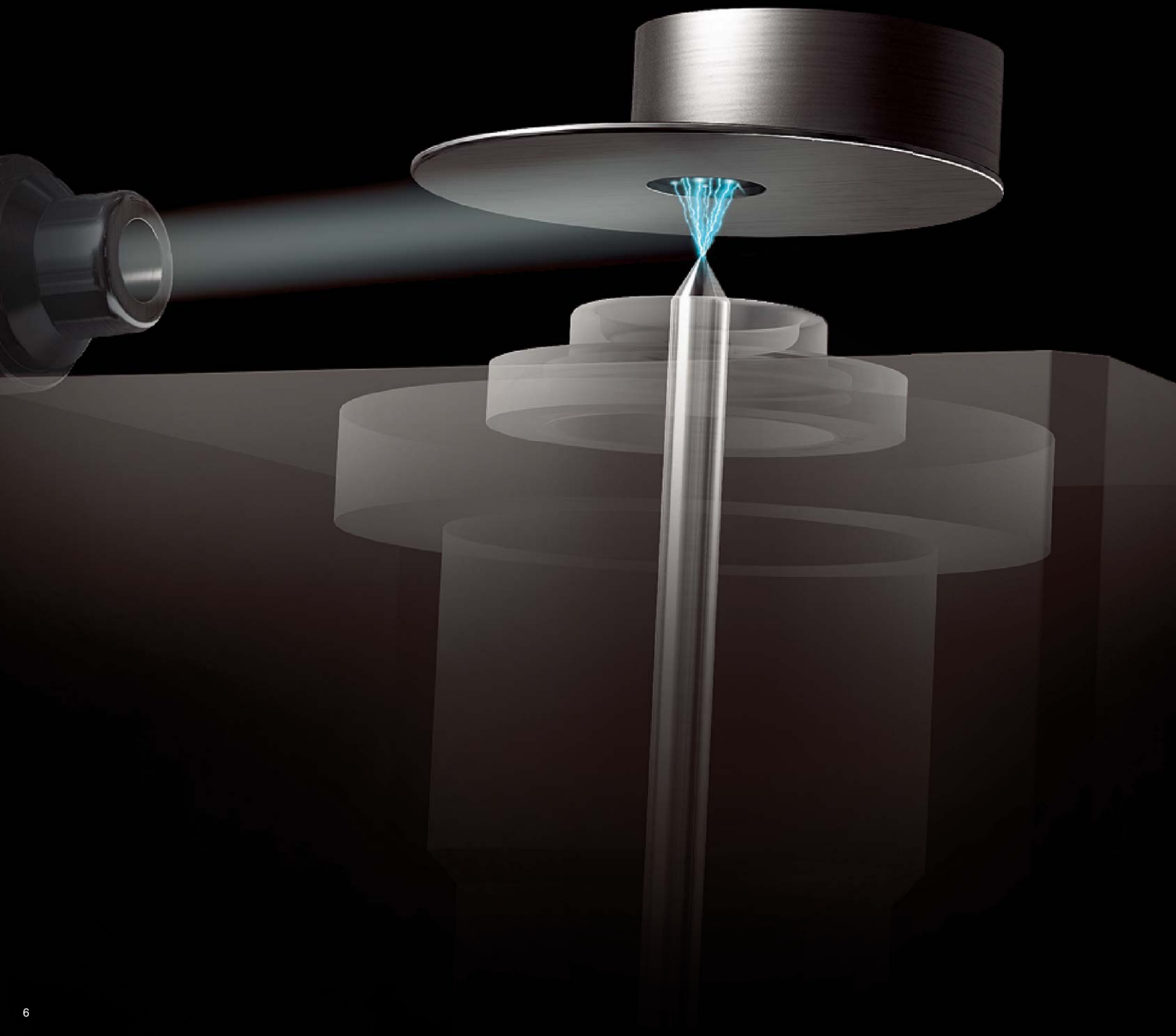
Table of Elements that can Be Measured

Measurable

H																	He
Li	Be											B	C	N	O	F	Ne
Na	Mg											Al	Si	P	S	Cl	Ar
K	Ca	Sc	Ti	V	Cr	Mn	Fe	Co	Ni	Cu	Zn	Ga	Ge	As	Se	Br	Kr
Rb	Sr	Y	Zr	Nb	Mo	Tc	Ru	Rh	Pd	Ag	Cd	In	Sn	Sb	Te	I	Xe
Cs	Ba	*L	Hf	Ta	W	Re	Os	Ir	Pt	Au	Hg	Tl	Pb	Bi	Po	At	Rn
Fr	Ra	**A															
		*L	La	Ce	Pr	Nd	Pm	Sm	Eu	Gd	Tb	Dy	Ho	Er	Tm	Yb	Lu
		**A	Ac	Th	Pa	U	Np	Pu	Am	Cm	Bk	Cf	Es	Fm	Md	No	Lr

A Novel Excitation Unit

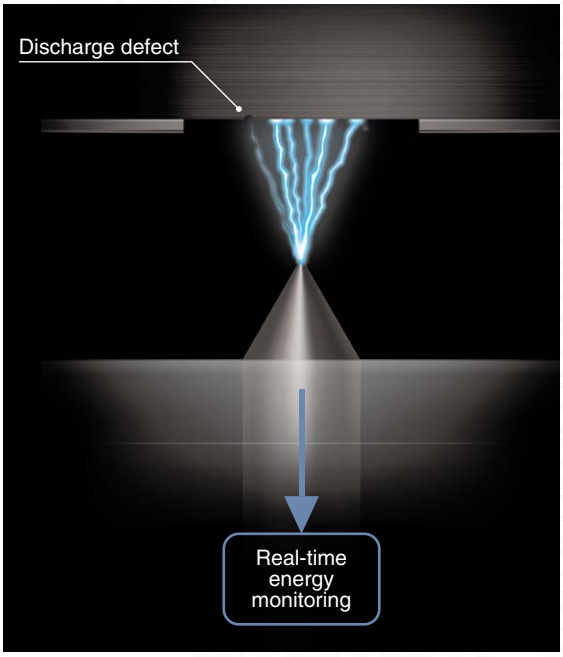
Equipped with real-time energy monitoring



Constant Monitoring of the Discharge Status

A Realtime Energy Monitoring* function is provided to monitor the discharge energy consumed between the counter electrode and the sample. The discharge energy is accurately set and controlled, and discharge defects due to the surface condition of the sample can be instantly detected from the discharge energy. The accuracy is improved by eliminating samples with defects from the measurement.

*Patent pending



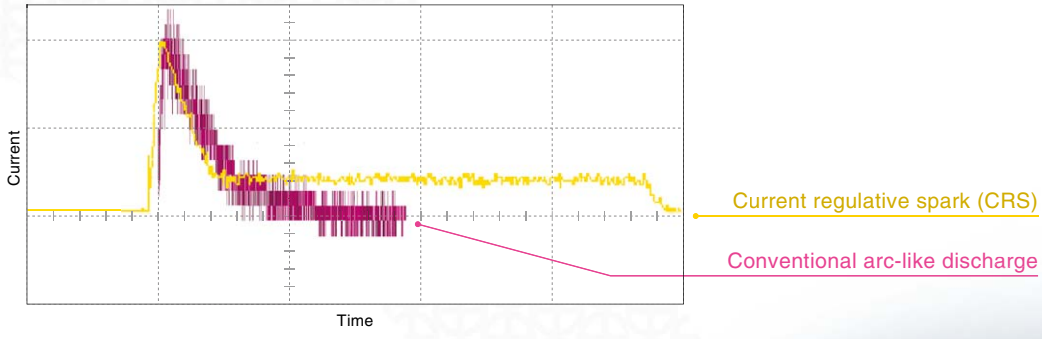
Supporting Diverse Metal Materials

Many metal materials can be analyzed over a wide range of optimal discharge conditions, such as high-energy discharge for metals like steel with a high melting point, or low-energy discharge for metals like lead and zinc alloys with a low melting point, through the use of a newly-developed discharge energy stabilizing excitation unit.

Ultra-Trace Analysis of High-Purity Materials

Current Regulative Spark* (CRS) which is capable of stabilizing the current for every pulse, improving sensitivity for trace amounts.

*Patent pending



Energy Efficient Design

The power consumption is reduced to 510W (43 % reduction from our previous Optical Emission Spectrometer)*1

*1 For analyzing 15 samples/hour

The argon gas consumption is also reduced by about 45 % from our previous Optical Emission Spectrometer.*2

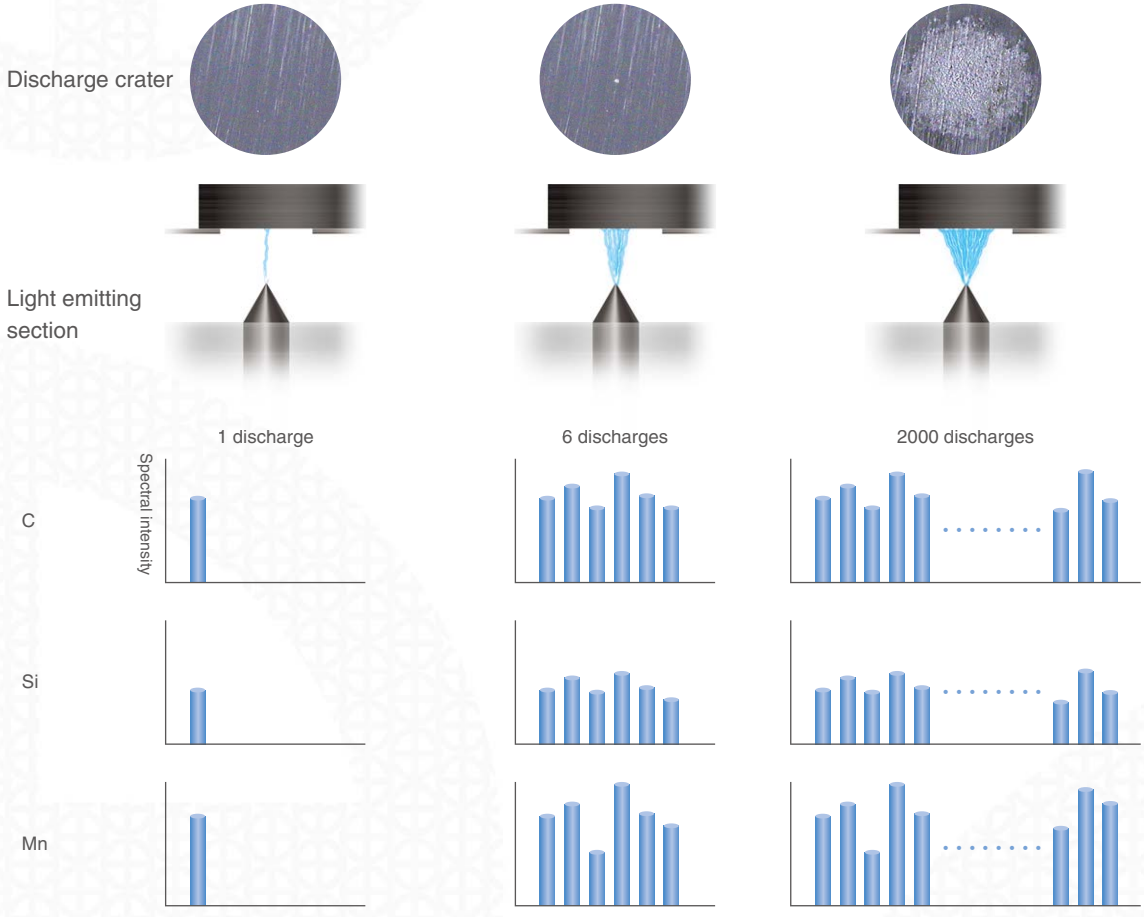
*2 The consumption for analyzing 150 samples/8 hours in 1 day

*Discharge spot

Shimadzu's Unique Pulse Distribution

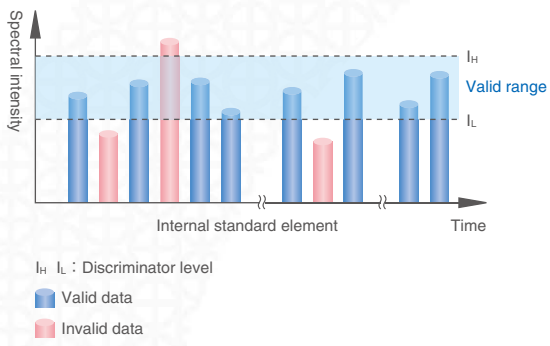
Pulse Height Distribution Analysis (PDA) Method Provided as Standard

The spectral intensity signal from the detector obtained for each pulse discharge is fed in for each analysis element, and converted into a frequency distribution. By performing statistical processing appropriate for each analysis element, the measurement accuracy can be improved and information on the element form can be extracted.



Internal Standard Element Monitoring

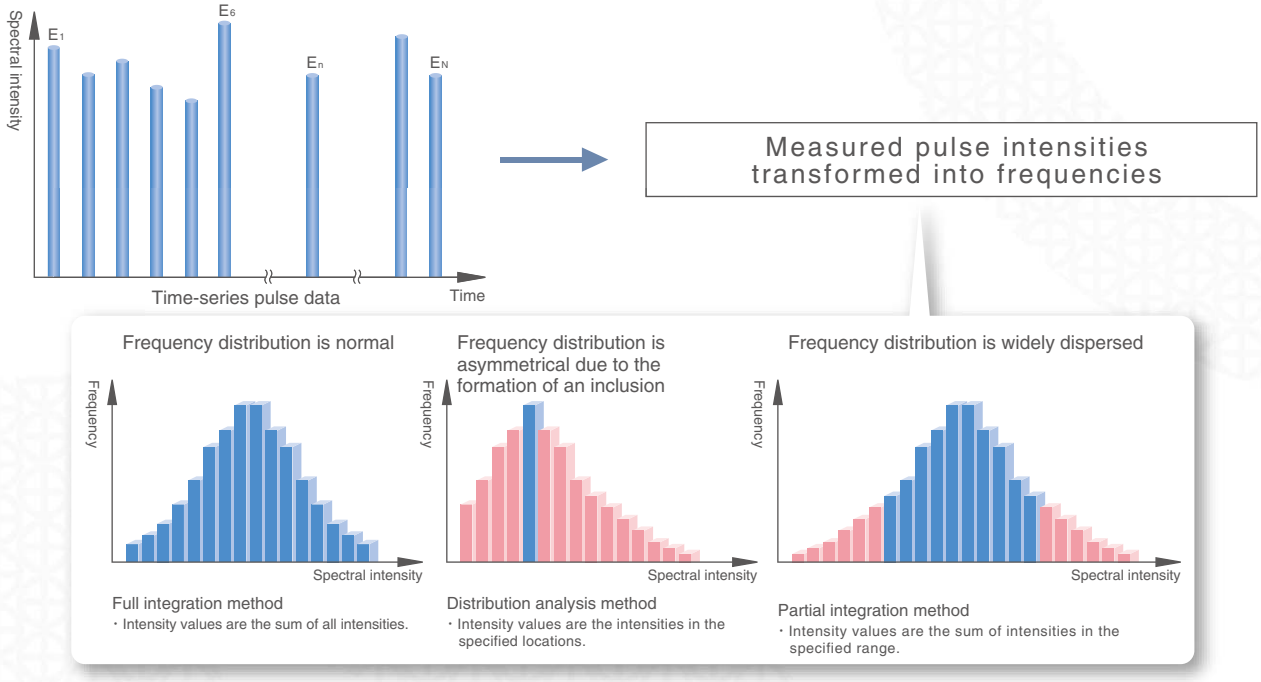
The spectral intensity of internal standard elements is monitored, and only pulses with the intensity within the specified range are processed as valid. Increased accuracy is achieved by eliminating the data outside the range from the statistical processing.



Analysis Photometry

Frequency Distribution Processing

Unlike conventional emission spectrometry that integrates the spectral intensity, Shimadzu's unique PDA method performs frequency distribution processing on the spectral intensity of each discharge pulse.
For example, when a discharge spot is applied to inclusions such as manganese sulfide (MnS) or aluminum oxide (Al_2O_3), the spectral intensity of that element is increased. When the spectral intensity of elements that readily form inclusions is converted into a frequency distribution, the distribution form is not symmetrical. For these elements that readily form inclusions, accurate results can be obtained by eliminating the data in the high intensity range from the statistical processing as inclusion data, using the distribution analysis method. For elements that do not form inclusions, the shape of the frequency distribution is symmetrical. Accuracy can be improved by selecting a processing method suitable for each element, such as the integration method that integrates all the spectral intensity, or the partial integration method that divides the spectral intensity.



Metallographic Analysis

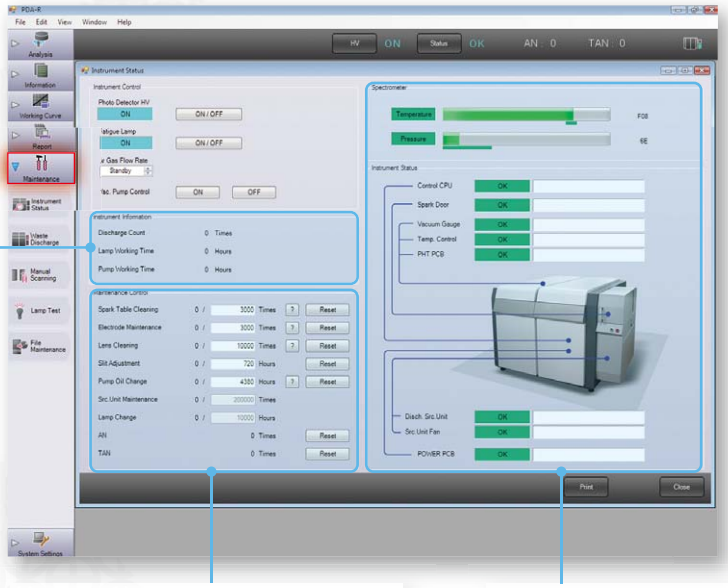
There are 2 forms of aluminum in steel: aluminum oxide (Al_2O_3: insoluble Al) existing as particles with diameters about 5 μm, and metallic aluminum (soluble Al).
The spectral intensity increases if aluminum oxide exists within the discharge spot.
After converting to a frequency distribution, information on aluminum oxides can be obtained from the part of the distribution with high spectral intensity.

Intuitive Software PDA-R

Total support for control and management of the instrument with an intuitive interface

Fusion of Hardware and Software

From control and diagnosis to maintenance - reliable instrument management with software integrated with the hardware.



The operating time of each part is controlled by each unit, so there is no problem when replacing PCs. Of course, they can be easily checked with the software.

The software supports complete maintenance management for stable use of the instrument.

- Lens cleaning procedure
- Electrode replacement
- Emission table cleaning
- Pump oil replacement
- Entrance slit adjustment
- Lamp replacement

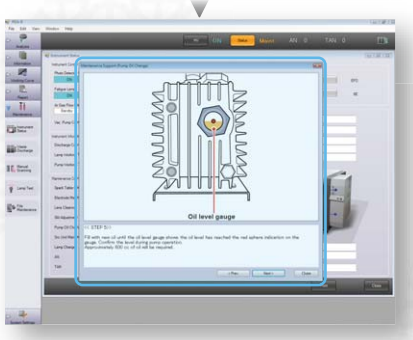
Instrument status displayed in real-time, down to the details.

- Instrument control system
- Excitation unit
- Photometer
- Monochromator temperature and pressure
- Vacuum meter
- Temperature adjustment system

When maintenance is required...

The software notifies you

And also...



Maintenance procedures are also supported. The instructions on the support screen provide guidance on the operations.

When troubles occur

The software warns you

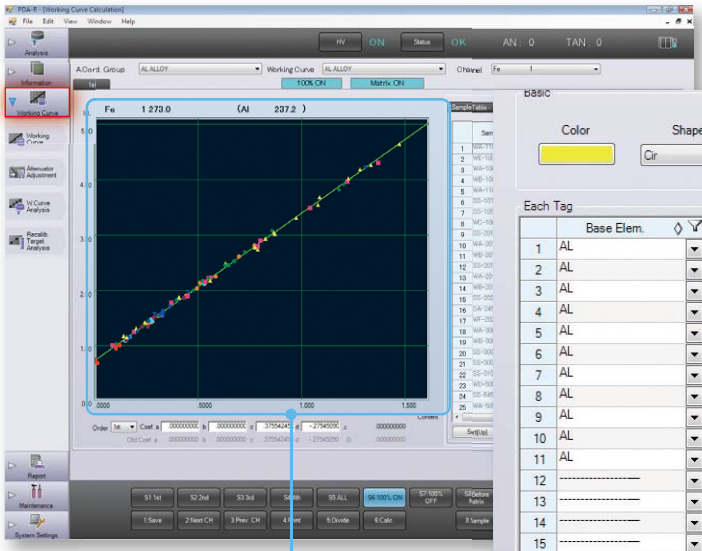
And also...

Abnormalities are automatically diagnosed and remedial measures are displayed.

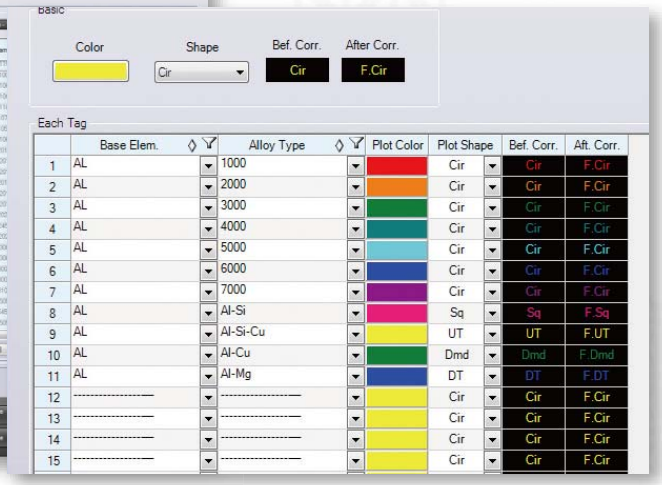
The Pursuit of Greater Ease-of-Use, Based on Reliability

A sophisticated, operator-friendly design has been developed utilizing our cumulative emission spectrometry experience.

Plots can be set for each sample, with more intuitive and easy-to-understand operation

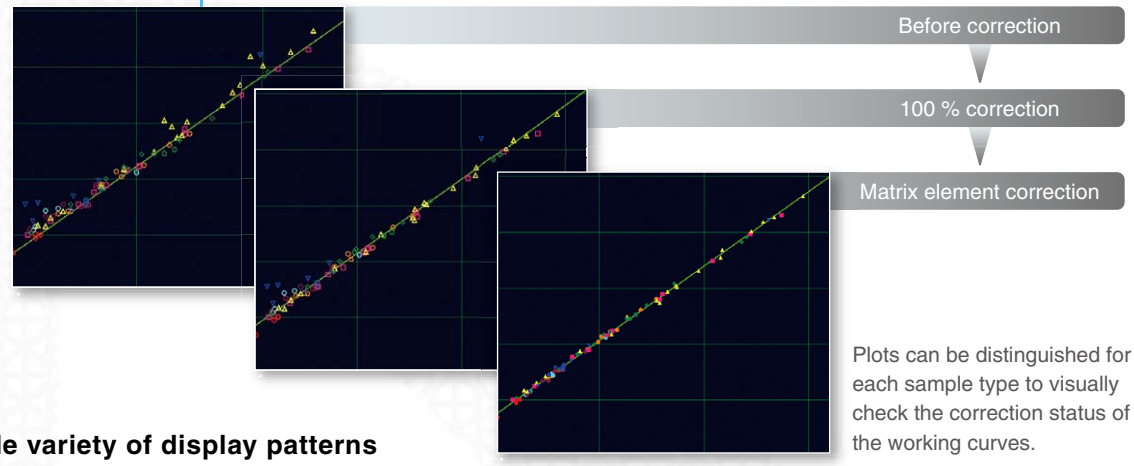


Working curve setting screen



	Base Elem.	Alloy Type	Plot Color	Plot Shape	Bef. Corr.	Aft. Corr.
1	AL	1000		Cir	Cir	F.Cir
2	AL	2000		Cir	Cir	F.Cir
3	AL	3000		Cir	Cir	F.Cir
4	AL	4000		Cir	Cir	F.Cir
5	AL	5000		Cir	Cir	F.Cir
6	AL	6000		Cir	Cir	F.Cir
7	AL	7000		Cir	Cir	F.Cir
8	AL	Al-Si		Sq	Sq	F.Sq
9	AL	Al-Si-Cu		UT	UT	F.UT
10	AL	Al-Cu		Dmd	Dmd	F.Dmd
11	AL	Al-Mg		DT	DT	F.DT
12	----------	----------		Cir	Cir	F.Cir
13	----------	----------		Cir	Cir	F.Cir
14	----------	----------		Cir	Cir	F.Cir
15	----------	----------		Cir	Cir	F.Cir

Working curve plot setting screen



Plots can be distinguished for each sample type to visually check the correction status of the working curves.

Wide variety of display patterns for analysis data

Analysis data control diagrams

Display pattern setting

Options

Electrode-Cleaning Unit
(P/N 211-78278-91)

To enhance long-term stability, the optional electrode-cleaning unit keeps the counter electrode clean by brushing away adhering sample deposits.

Automatic sample retainer mechanism

Stand Water-Cooling Kit
(P/N: 211-78899-91)

Used to reduce the effect of the heat energy generated by high-energy discharge. A separate cooling water circulator is necessary.

Cooling Water Circulator
(P/N 044-01809-06)

Small Sample Kit
(P/N: 211-78904-)**

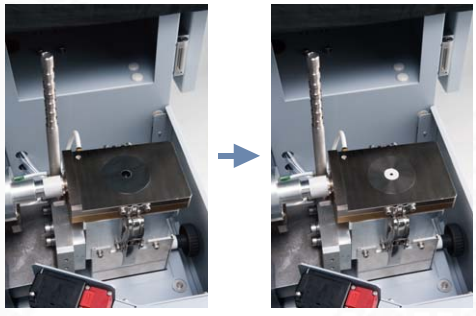
Handles samples between 3 mm and 12 mm in diameter.

Sample diameter

φ3 mm or more	P/N 211-78904-02
φ4 mm or more	P/N 211-78904-03
φ5 mm or more	P/N 211-78904-04
φ6 mm or more	P/N 211-78904-05
φ7 mm or more	P/N 211-78904-06
φ8 mm or more	P/N 211-78904-07
φ9 mm or more	P/N 211-78904-08

* When ordering multiple parts at the same time or adding to the existing instrument, the emission table and the Mylar in each small sample kit can be used in common, so only obtain the insulating washer for each hole diameter (P/N 211-78907-02 to 08).

①Emission table
②Insulating washer
③Mylar



Pin Sample Kit
(P/N 211-78901-91)

Handles wire or bolts between 0.6 mm and 12 mm in diameter.

Pin Sample Holder
(P/N 202-40597-)**

* Various types of pin sample holders are available. Select the specification to suit the sample diameter.

Consumables

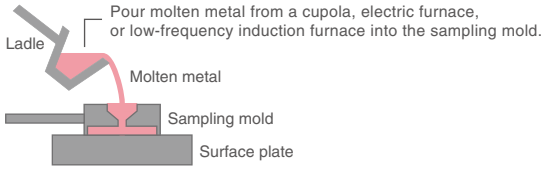
1. Tungsten Electrode	P/N 211-78953-91
2. Brush	P/N 211-74965
3. Pump Oil, 1 liter	P/N 017-30159-03
4. Grinding Wheel (for MT-11M)	P/N 085-50802-51

Options for Sample Preparation

Sampling Mold
(P/N 210-00005)

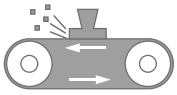
Surface Plate
(P/N 210-00006)

Size: W300 × D300 × H100 mm



FS-3N (Special)
Belt Grinder with Dust Collector
(50 Hz: P/N 085-50206-15)
(60 Hz: P/N 085-50206-16)

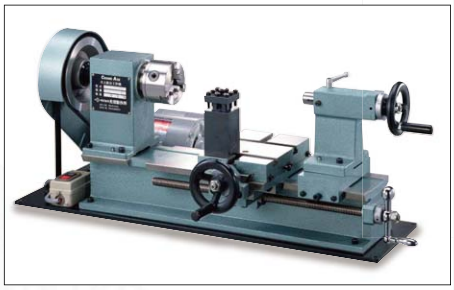
Size: W441 × D680 × H883 mm
Weight: Approx. 97 kg
Power Supply: 3-phase 200 V 1150 W



L-1000 MM-02 Bench Lathe
(P/N 085-50102-02)

Size: W770 × D420 × H350 mm
Weight: Approx. 75 kg
Power Supply: Single phase 100 V 300 W
Order the following 1) and 2) with the bench lathe.

1)Tip holder TCGCR/L1010F-08
P/N 085-50102-12
2)Tip for non-ferrous TCGT080202FR/L-U KW10
P/N 085-50102-13
3)E-17 Bench Lathe Stand
P/N 085-50102 -11
Size: W1200 × D600 × H740 mm

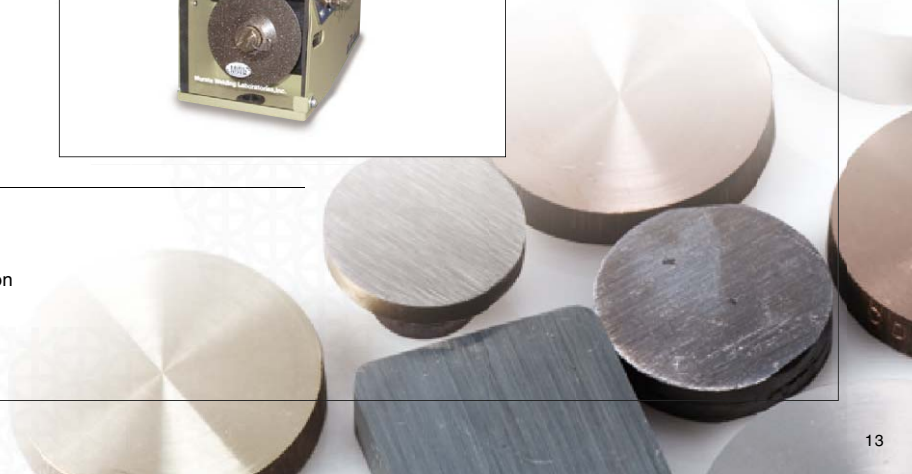


MT-11M Counter Electrode Grinder
(for 6 mm diameter tungsten electrodes)
(P/N 085-50802-01)

Size: W120 × D210 × H150 mm
Weight: Approx. 3 kg
Power Supply: Single phase 100 V 100 W

Standard Analysis Samples

Contact your Shimadzu representative for information on the selection and preparation of standard samples for each analysis purpose.



Specifications

Spectrometer Unit	
Optical system	Paschen-Runge mount
Monochromator	With temperature control
Excitation Unit	
Excitation unit	REM power supply
Emission table	Argon gas atmosphere
Software	
No. of processing channels	64 channels max.
Standard sample registration	10000 samples max.
Matrix element correction	32 elements max./element
Correction	100 % correction
	Master curve correction
Analysis function	Content analysis (four-time analysis, round analysis)
Analysis processing	Recycling
	Additional analysis
	Canceling
	Ending
	Display/print order and number of digit settings
Analysis result transmission	RS232C
	LAN (TCP/IP)
Analysis results display	$\overline{X}$-R control chart
	Histogram
Maintenance	Maintenance period control
Password	Protection of analysis information

Installation and Optional Accessories

Installation Environment

Temperature : 15 °C to 30 °C

Humidity : 70 % max.

Power Supply : Single phase 200 V ±10 % 50/60 Hz 1.5 kVA

Installation : Separate, 30 Ω max.

Argon Gas : Purity 99.999 % min. Dew point -70 °C max.

A switching system with 2 or more 7m³ cylinders is convenient

Optional Accessories

(Installation spaces and power supplies are required separately.)

- Sampling Mold and Surface Plate
- L-1000 Bench lathe : Single phase 100 V 300 W
- Belt Grinder with Dust Collector : 3-phase 200 V 1150 W
- MT-11M Counter Electrode Grinder : Single phase 100 V 100 W

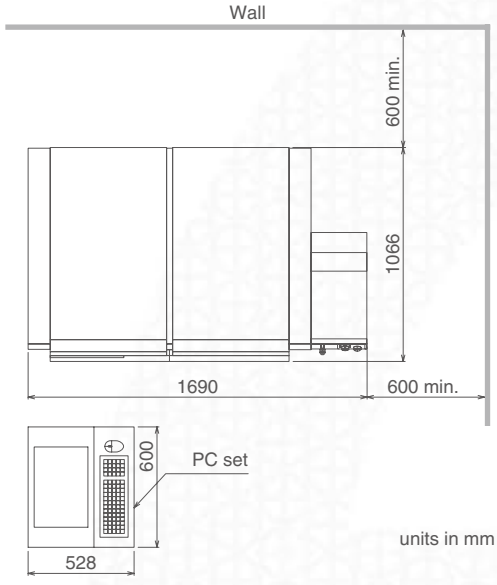
External Dimensions and Weight

PDA Instrument : W1690 × D1066 × H1142 mm

PC Set : W650 × D600 × H1380 mm

Weight : Approx. 600 kg

* For installation details, refer to the Pre-Installation Requirement.



Testing Instruments and X-ray Inspection Systems

Physical properties evaluation (Strength test • Fatigue and Endurance test)

High-precision Universal tester

AG-X Series

Designed for reliability and ease-of-use, these precision universal testers provide high control and measurement performance. For the three most important functions of a testing machine - setting, measurement, and inspection - enjoy the highest level of performance available. TRAPEZIUM X PC software uses state-of-the-art .NET technology to ensure operation is easier than ever. Additionally, perform tests without a computer via a color TFT touch panel, use the USB memory function to directly set test parameters created previously on a PC, and then easily transfer result data to a USB device. Choose from several floor-type and tabletop models to fit your application needs.

AG-300kNX

Universal Testing Machines

UH-FI Series

Equipped with front-opening hydraulic grips, this series allows the performing of tensile testing with high efficiency. By adding options, such as an automatic extensometer and data processing equipment, these models can be used as automatic tensile testing systems.

- Capacity : 300, 500, 600, 1000, 2000, 3000 or 4000 kN (seven models)
- Test Force Range : x1 to x50, in 6 steps
- Grips : Front-Opening Hydraulic Type
- Computer Control Functions :
  Single test, cycle test, metal tensile test, high-temperature tensile test, and 3-step stroke speed switching

UH-F 500kNI

Micro Hardness Tester

HMV Series

The HMV-2 is equipped with an automatic test force switching feature that allows the touch panel to perform operations ranging from selecting the test force loading to the time duration of the test force. Models with an electric turret (HMV-2T) are capable of automatically switching from load application to surface viewing. A direct link with Windows allows the data to be exported to an Excel file.

- Test Force Range : 98.07mN to 19.61N (HMV-2/2T)
- Min. Measurement Unit : 0.01μm
- Type with Electric Revolver : (HMV-2T)

HMV-2

Observation of sample interiors (X-ray Inspection Systems)

X-ray Inspection Systems

SMX-3500

Equipped with a stage for large samples and a shielded chamber, the SMX-3500 X-ray inspection system combines a high-output x-ray unit and a detector with a large FOV, enabling observation and detection of internal defects in aluminum die cast and other materials. Performing all operations with a single mouse allows the operator to focus on inspection. In addition, this instrument uses a variety of state-of-the-art technologies such as positioning via external image (external navigation) and observation point tracking in 3D (tracking), making observation simple from any angle.

SMX-3500

JQA-0376

Founded in 1875, Shimadzu Corporation, a leader in the development of advanced technologies, has a distinguished history of innovation built on the foundation of contributing to society through science and technology. We maintain a global network of sales, service, technical support and applications centers on six continents, and have established long-term relationships with a host of highly trained distributors located in over 100 countries. For information about Shimadzu, and to contact your local office, please visit our Web site at **www.shimadzu.com**

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